

# Disturbance modeling for robust control of ill-conditioned processes with MPC

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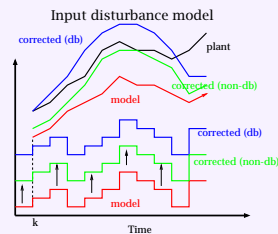
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## Introduction

A multivariable process is ill-conditioned when some manipulated inputs **have almost the same effect** on the controlled outputs. Ill-conditioned processes are **frequent** in the process industries (e.g. **distillation** processes). They show **large interactions** and **directionality**.

If an ill-conditioned process is controlled with **decentralized loops** (e.g. PI), the performance suffers from **interactions** between control loops. On the other hand, if we use **DMC controllers** (centralized), **excellent nominal performance** is obtained, but **poor robustness to input uncertainty** is shown.



- They guarantee **offset-free** control (Muske and Rawlings, 1993)
- Pure **output disturbances** are **unlikely to occur** in the process industries. *In fact, the load always enters upstream of a dominant time constant and, in many cases, at the same point as the manipulated variable* (Shinsky, 1994)
- **DMC**, which uses an output disturbance model, **does not** quickly reject **slow disturbances** (Morari and Lee, 1991)

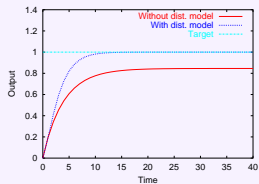
## MPC and disturbance models

### Necessity of a disturbance model

Example:

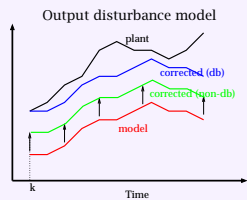
$$g_m(s) = \frac{1}{10s + 1}$$

$$g_p(s) = \frac{1.5}{10s + 1}$$



A disturbance model is required to correct the model forecasting and to obtain **offset-free control** in the presence of plant-model mismatch and/or unmodeled disturbances.

### Input and output disturbance model



### Optimal disturbance model

We define a general disturbance model as:

$$x_{k+1} = Ax_k + Bu_k + Dd_k + \xi_k^x$$

$$d_{k+1} = d_k + \xi_k^d$$

$$y_k = Cx_k + Pd_k + v_k$$

A state-space representation of the **closed-loop system** is:

$$z_{k+1} = \Lambda z_k + \Xi \hat{y} + \Theta \hat{d}$$

$$y_k = \Gamma z_k + P_p \hat{d}$$

in which  $z_k = [x_k \ \hat{x}_{k|k} \ \hat{d}_{k|k} \ u_{k-1}]^T$ . The **closed-loop true objective function** is found by solving a Lyapunov equation:

$$\Phi = \tilde{z}_0^T \tilde{S} \tilde{z}_0$$

$$\tilde{S} = \tilde{Q} + \Psi^T \tilde{S} \Psi$$

in which  $\tilde{z}_0 = [z_0^T \ y^T \ d^T]^T$ . We find the **"optimal" disturbance model**, which guarantees the **best performance in the worst case of plant uncertainty**:

$$\min_{D,P} \left[ \max_{\text{Plant uncertainty}} \Phi \right]$$

## Case study: composition control of a distillation column

### Model and uncertainty

Skogestad and Morari (1987) with minor changes (Lundström et al., 1995):

$$\begin{bmatrix} y^D \\ x_B \end{bmatrix} = e^{-\theta s} \begin{bmatrix} \frac{0.878}{1+\tau_1 s} & \frac{0.014}{1+\tau_2 s} - \frac{0.878}{1+\tau_1 s} \\ \frac{1.082}{1+\tau_1 s} & \frac{1.082}{1+\tau_2 s} - \frac{1.082}{1+\tau_1 s} \end{bmatrix} \begin{bmatrix} L_t \\ V_b \end{bmatrix}$$

$$\tau_1 = 194; \quad \tau_2 = 15; \quad \theta = 1$$

$$g_L(s) = \frac{1}{(1 + \theta L/5s)^3}$$

**Independent input uncertainty** is considered:

$$L_t^{\text{actual}} = L_t^{\text{computed}} (1 + \delta_1)$$

$$V_b^{\text{actual}} = V_b^{\text{computed}} (1 + \delta_2)$$

in which  $|\delta_1, \delta_2| \leq 0.2$

### Optimal disturbance model

The **general disturbance model** is:

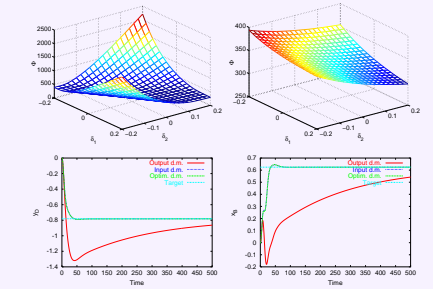
$$D = B \begin{bmatrix} \omega_1^D & 0 \\ 0 & \omega_2^D \end{bmatrix}; \quad P = \begin{bmatrix} \omega_1^P & 0 \\ 0 & \omega_2^P \end{bmatrix}$$

in which  $\omega_i^D, \omega_i^P \in [0, 1]$ . For several cases of setpoint change and disturbance rejection, the **optimal disturbance model** is found by solving:

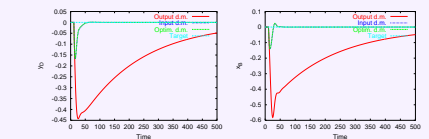
$$\min_{\omega_1^D, \omega_2^D, \omega_1^P, \omega_2^P} \max_{\delta_1, \delta_2} \Phi$$

### Setpoint change in the unfavorable direction

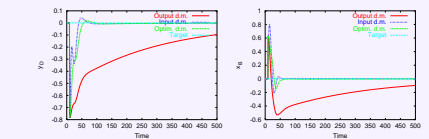
Output disturbance model      Input disturbance model



### Rejection of an input disturbance in the favorable direction



### Rejection of an output disturbance in the unfavorable direction



## Comments

- Repeating the optimization for **different directions** of the **setpoint** and of the **plant disturbance** we found that the optimal disturbance models **change slightly**
- For **setpoint changes** and **input disturbance rejections**, the optimal disturbance models are close to the **input disturbance model**
- For **output disturbance rejections** the optimal disturbance models are a **combination** of input and output disturbance model

## Conclusions

- Analyzed the implications of the **disturbance model** on the robustness of MPC for **ill-conditioned** processes
- Proposed a method for **searching the "optimal" disturbance model** by solving a **min-max optimization problem**
- For ill-conditioned processes, the **output disturbance model** as in DMC shows **poor robustness** to input uncertainty
- For ill-conditioned processes, the **input disturbance model** is **more robust** and, in several cases, is **close to the optimal disturbance model**